

# MOSFET - Power, Single N-Channel, SUPERFET<sup>®</sup> V, FRFET<sup>®</sup>, TO247-3L 600 V, 40 mΩ, 59 A

# NVHL040N60S5F

#### Description

The SUPERFET V MOSFET FRFET series has optimized body diode performance characteristics. This can allow for the removal of components in the application and improve application performance and reliability, particularly when soft switching topologies are used.

#### **Features**

- 650 V @  $T_J = 150^{\circ}C / Typ. R_{DS(on)} = 32 \text{ m}\Omega$
- 100% Avalanche Tested
- Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- Electric Vehicle On Board Chargers
- EV Main Battery DC/DC Converters

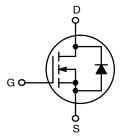
#### ABSOLUTE MAXIMUM RATINGS (T. J = 25°C, Unless otherwise noted)

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage	V <sub>DSS</sub>	600	V	
Gate-to-Source Voltage	DC	$V_{GSS}$	±30	V
	AC (f > 1 Hz)		±30	
Continuous Drain Current	T <sub>C</sub> = 25°C	I <sub>D</sub>	59	Α
	T <sub>C</sub> = 100°C		37	
Power Dissipation	T <sub>C</sub> = 25°C	$P_{D}$	347	W
Pulsed Drain Current (Note 1)	T <sub>C</sub> = 25°C	I <sub>DM</sub>	209	Α
Pulsed Source Current (Body Diode) (Note 1)	T <sub>C</sub> = 25°C	I <sub>SM</sub>	209	Α
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C
Source Current (Body Diode)		Is	59	Α
Single Pulse Avalanche Energy	$I_L$ = 8.3 A, $R_G$ = 25 $\Omega$	E <sub>AS</sub>	574	mJ
Avalanche Current	I <sub>AS</sub>	8.3	Α	
Repetitive Avalanche Energy (N	E <sub>AR</sub>	3.47	mJ	
MOSFET dv/dt		dv/dt	120	V/ns
Peak Diode Recovery dv/dt (No		70		
Lead Temperature for Soldering Purposes (1/8" from case for 10 seconds)		T <sub>L</sub>	260	°C

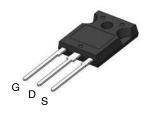
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Repetitive rating: pulse-width limited by maximum junction temperature.
- 2.  $I_{SD} \le 29.5$  A, di/dt  $\le 200$  A/ $\mu$ s,  $V_{DD} \le 400$  V, starting  $T_J = 25$ °C.

V <sub>DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
600 V	40 mΩ @ 10 V	59 A

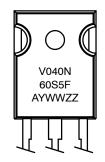


**POWER MOSFET** 



TO-247 Long Leads CASE 340CX

#### **MARKING DIAGRAM**



V040N60S5F = Specific Device Code
A = Assembly Location
YWW = Date Code (Year & Week)
ZZ = Assembly Lot

#### ORDERING INFORMATION

Device	Package	Shipping
NVHL040N60S5F	TO-247	30 Units / Tube

#### THERMAL CHARACTERISTICS

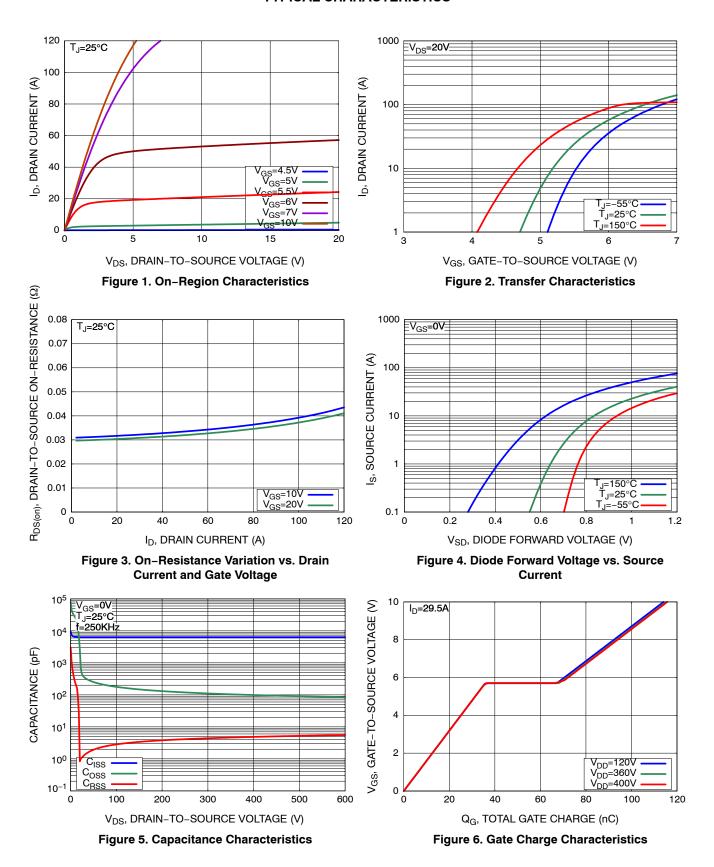
Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case, Max.	$R_{ heta JC}$	0.36	°C/W
Thermal Resistance, Junction-to-Ambient, Max.	$R_{ hetaJA}$	40	

#### **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V, } I_D = 1 \text{ mA, } T_J = 25^{\circ}\text{C}$	600	-	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$\Delta V_{(BR)DSS}/$ $\Delta T_J$	I <sub>D</sub> = 10 mA, Referenced to 25°C	-	630	-	mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}, T_{J} = 25^{\circ}\text{C}$	-	-	10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±30 V, V <sub>DS</sub> = 0 V	_	-	±100	nA
ON CHARACTERISTICS						
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}, I_D = 29.5 \text{ A}, T_J = 25^{\circ}\text{C}$	-	32	40	$m\Omega$
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{GS} = V_{DS}, I_D = 7.2 \text{ mA}, T_J = 25^{\circ}\text{C}$	3.2	-	4.8	V
Forward Trans-conductance	9FS	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 29.5 A	-	59.5	-	S
CHARGES, CAPACITANCES & GATE	RESISTANCE					
Input Capacitance	C <sub>ISS</sub>	$V_{DS} = 400 \text{ V}, V_{GS} = 0 \text{ V}, f = 250 \text{ kHz}$	-	6318	-	pF
Output Capacitance	C <sub>OSS</sub>		-	98.9	-	
Time Related Output Capacitance	C <sub>OSS(tr.)</sub>	$I_D$ = Constant, $V_{DS}$ = 0 V to 400 V, $V_{GS}$ = 0 V	-	1478	-	-
Energy Related Output Capacitance	C <sub>OSS(er.)</sub>	V <sub>DS</sub> = 0 V to 400 V, V <sub>GS</sub> = 0 V	_	170	-	
Total Gate Charge	Q <sub>G(tot)</sub>	V <sub>DD</sub> = 400 V, I <sub>D</sub> = 29.5 A, V <sub>GS</sub> = 10 V	-	115	-	nC
Gate-to-Source Charge	$Q_{GS}$		-	35.9	-	
Gate-to-Drain Charge	$Q_{GD}$		_	32.7	-	
Gate Resistance	$R_{G}$	f = 1 MHz	-	4.5	_	Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{GS} = 0/10 \text{ V}, V_{DD} = 400 \text{ V},$	-	49.6	-	ns
Rise Time	t <sub>r</sub>	$I_D = 29.5 \text{ A}, R_G = 2.2 \Omega$	-	85.9	-	
Turn-Off Delay Time	t <sub>d(off)</sub>		-	110	-	
Fall Time	t <sub>f</sub>	1	_	2.5	-	
SOURCE-TO-DRAIN DIODE CHARAC	TERISTICS					
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V}, I_{SD} = 29.5 \text{ A}, T_{J} = 25^{\circ}\text{C}$	_	-	1.2	V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V}, I_{SD} = 29.5 \text{ A},$	-	140	-	ns
Reverse Recovery Charge	Q <sub>RR</sub>	dl/dt = 100 A/μs, V <sub>DD</sub> = 400 V	-	917	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL CHARACTERISTICS**



#### **TYPICAL CHARACTERISTICS**

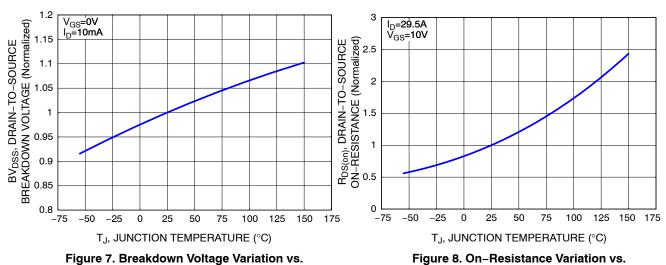


Figure 7. Breakdown Voltage Variation vs.
Temperature

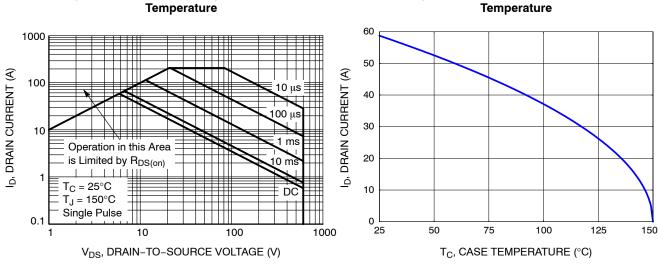


Figure 9. Maximum Safe Operating Area

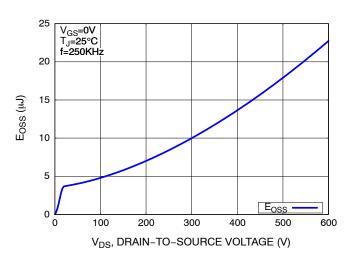


Figure 11. E<sub>OSS</sub> vs. Drain-to-Source Voltage

Figure 10. Maximum Drain Current vs. Case Temperature

# **TYPICAL CHARACTERISTICS**

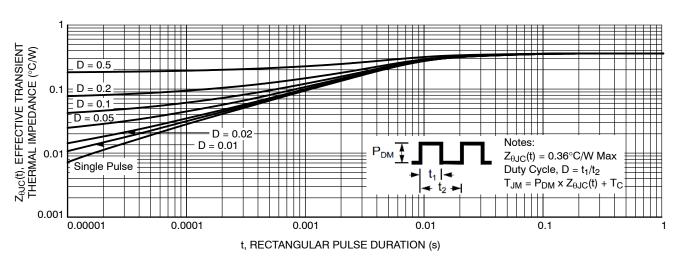


Figure 12. Transient Thermal Impedance

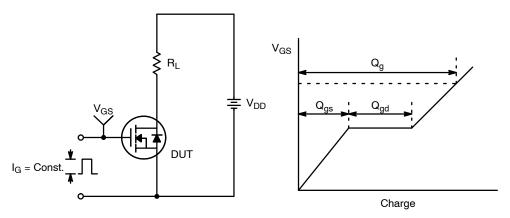


Figure 13. Gate Charge Test Circuit & Waveform

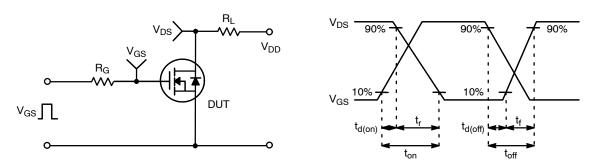


Figure 14. Resistive Switching Test Circuit & Waveforms

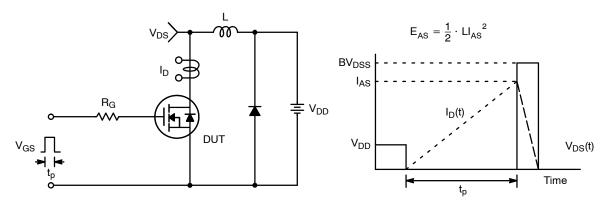


Figure 15. Unclamped Inductive Switching Test Circuit & Waveforms

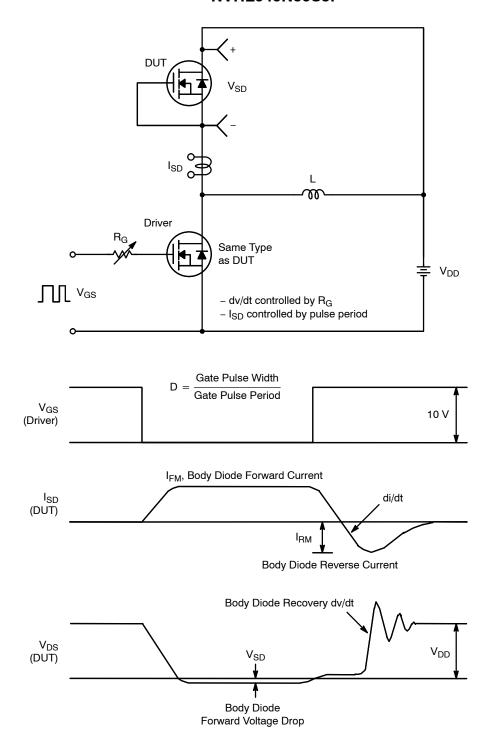
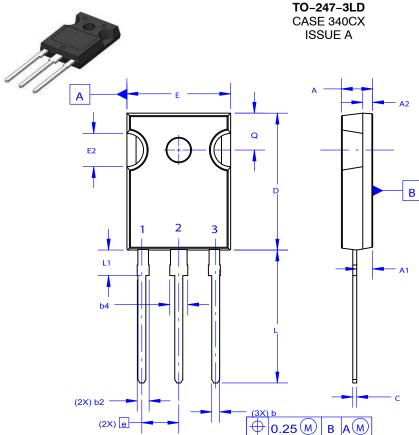
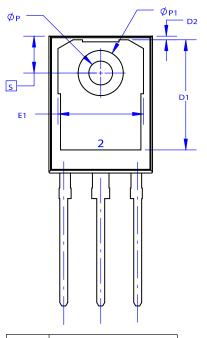


Figure 16. Peak Diode Recovery dv/dt Test Circuit & Waveforms

SUPERFET and FRFET are a registered trademarks of Semiconductor Components Industries, LLC or its subsidiaries in the United States and/or other countries.



**DATE 06 JUL 2020** 

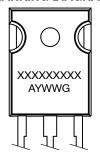


#### NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

  B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

# **GENERIC MARKING DIAGRAM\***



XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " =", may or may not be present. Some products may not follow the Generic Marking.

DIM	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.58	4.70	4.82		
<b>A</b> 1	2.20	2.40	2.60		
A2	1.40	1.50	1.60		
D	20.32	20.57	20.82		
Е	15.37	15.62	15.87		
E2	4.96	5.08	5.20		
е	~	5.56	~		
L	19.75	20.00	20.25		
L1	3.69	3.81	3.93		
ØΡ	3.51	3.58	3.65		
Q	5.34	5.46	5.58		
S	5.34	5.46	5.58		
b	1.17	1.26	1.35		
b2	1.53	1.65	1.77		
b4	2.42	2.54	2.66		
С	0.51	0.61	0.71		
D1	13.08	~	~		
D2	0.51	0.93	1.35		
E1	12.81	~	~		
ØP1	6.60	6.80	7.00		

DOCUMENT NUMBER:	98AON93302G	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	TO-247-3LD		PAGE 1 OF 1	

ON Semiconductor and un are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, Onsemi, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase

#### ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$ 

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales